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Fairchild Semiconductor FDS6675A

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February 2003

FDS6675A

30V P-Channel PowerTrench® MOSFET

General Description

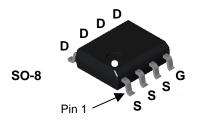
This P-Channel MOSFET is a rugged gate version of Fairchild Semiconductor's advanced PowerTrench process. It has been optimized for power management applications requiring a wide range of gate drive voltage ratings (4.5V – 25V).

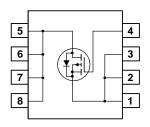
Applications

- Power management
- Load switch
- Battery protection

Features

- -11 A, -30 V $R_{DS(ON)} = 13 \text{ m}\Omega$ @ $V_{GS} = -10 \text{ V}$ $R_{DS(ON)} = 19 \text{ m}\Omega$ @ $V_{GS} = -4.5 \text{ V}$
- · Low gate charge
- · Fast switching speed
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$
- · High power and current handling capability





Absolute Maximum Ratings T_A=25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		-30	V
V _{GSS}	Gate-Source Voltage		±25	V
I _D	Drain Current - Continuous	(Note 1a)	-11	А
	- Pulsed		-50	
P _D	Power Dissipation for Single Operation	(Note 1a)	2.5	W
		(Note 1b)	1.2	
		(Note 1c)	1	
T _J , T _{STG}	Operating and Storage Junction Tempera	ture Range	-55 to +175	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	50	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1c)	125	°C/W
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	(Note 1)	25	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDS6675A	FDS6675A	13"	12mm	2500 units



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Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Char	acteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	-30			V
<u>ΔBV_{DSS}</u> ΔT _J	Breakdown Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}$, Referenced to 25°C		-23		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = -24 \text{ V}, V_{GS} = 0 \text{ V}$			-10	μΑ
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 25 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
On Char	racteristics (Note 2)					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-1	-1.6	-3	V
$\Delta V_{GS(th)} \over \Delta T_J$	Gate Threshold Voltage Temperature Coefficient	$I_D = -250 \mu\text{A}$, Referenced to 25°C		5		mV/°C
R _{DS(on)}	Static Drain–Source On–Resistance	$\begin{split} V_{GS} &= -10 \text{ V}, & I_D &= -11 \text{ A} \\ V_{GS} &= -4.5 \text{ V}, & I_D &= -9 \text{ A} \\ V_{GS} &= -10 \text{ V}, I_D &= -11 \text{ A}, T_J &= 125^{\circ}\text{C} \end{split}$		10 15 14	13 19 18	mΩ
I _{D(on)}	On-State Drain Current	$V_{GS} = -10 \text{ V}, \qquad V_{DS} = -5 \text{ V}$	-50			Α
g FS	Forward Transconductance	$V_{DS} = -5 \text{ V}, \qquad I_{D} = -11 \text{ A}$		34		S
Dvnamio	Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = -15 \text{ V}.$ $V_{GS} = 0 \text{ V}.$		2330		pF
Coss	Output Capacitance	f = 1.0 MHz		610		pF
C _{rss}	Reverse Transfer Capacitance			300		pF
Rg	Gate Resistance	V_{GS} =15 mV f= 1.0 MHz		4		mΩ
Switchir	ng Characteristics (Note 2)					
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -15 \text{ V}, \qquad I_D = -1 \text{ A},$		14	25	ns
t _r	Turn-On Rise Time	$V_{GS} = -10 \text{ V}, R_{GEN} = 6 \Omega$		12	22	ns
$t_{d(off)}$	Turn-Off Delay Time	OS I , OLN I		70	110	ns
t _f	Turn–Off Fall Time			37	60	ns
Q_g	Total Gate Charge	$V_{DS} = -15 \text{ V}, \qquad I_{D} = -11 \text{ A},$		24	34	nC
Q_{gs}	Gate–Source Charge	$V_{GS} = -5 V$		6		nC
Q_{gd}	Gate-Drain Charge			9		nC
Drain-S	ource Diode Characteristics ar	nd Maximum Ratings				
Is	Maximum Continuous Drain-Source Di				-2.1	Α
V_{SD}	Drain–Source Diode Forward Voltage			-0.7	-1.2	V
trr	Diode Reverse Recovery Time	$I_F = -11A$		33		ns
Qrr	Diode Reverse Recovery Charge	$d_{iF}/d_t = 100A/\mu s$		15		nC

Notes

 R_{8,1A} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{8,1C} is guaranteed by design while R_{8,CA} is determined by the user's board design.



a) 50°C/W when mounted on a 1in² pad of 2 oz copper



b) 105°C/W when mounted on a .04 in² pad of 2 oz copper



c) 125°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

2. Pulse Test: Pulse Width < 300 μ s, Duty Cycle < 2.0%





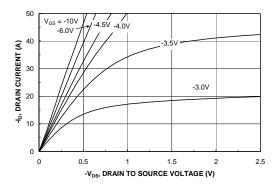


Figure 1. On-Region Characteristics.

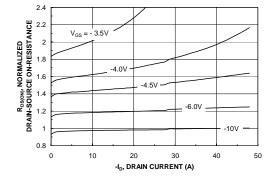


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

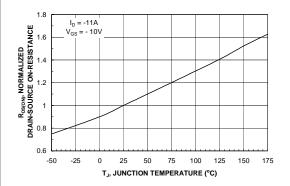


Figure 3. On-Resistance Variation with Temperature.

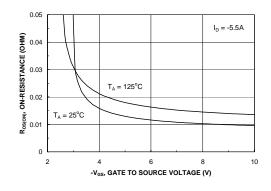


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

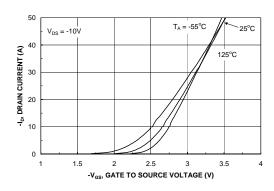


Figure 5. Transfer Characteristics.

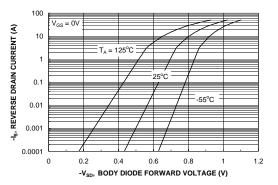
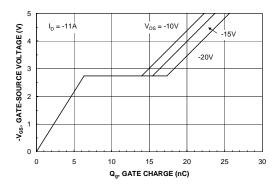


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.



Typical Characteristics



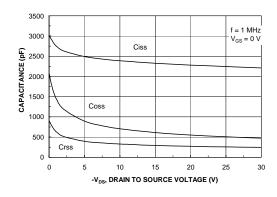
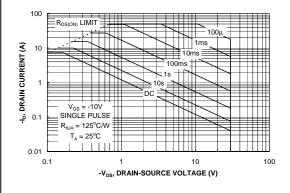


Figure 7. Gate Charge Characteristics.

Figure 8. Capacitance Characteristics.



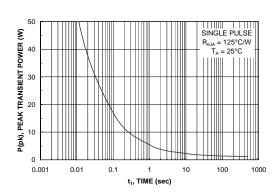


Figure 9. Maximum Safe Operating Area.

Figure 10. Single Pulse Maximum Power Dissipation.

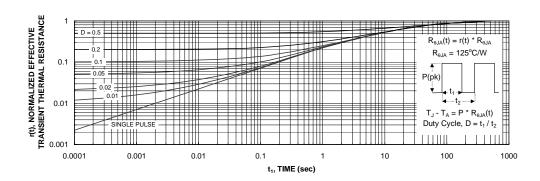


Figure 11. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.



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